INTEGRATED CIRCUITS

DATA SHEET

74ALVT16344 2.5V/3.3V 1-to-4 address driver (3-State)

Product specification

1998 Jun 30

IC24 Data Handbook





2.5V/3.3V 1-to-4 address driver (3-State)

74ALVT16344

FEATURES

- Multiple V_{CC} and GND pins minimize switching noise
- 5V I/O Compatible
- Live insertion/extraction permitted
- 3-State output buffers
- Power-up 3-State
- Output capability: +64mA/-32mA
- Latch-up protection exceeds 500mA per Jedec JC40.2 Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model

DESCRIPTION

The 74ALVT16344 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive. It is designed for V_{CC} operation at 2.5V or 3.3V with I/O compatibility to 5V.

The 74ALVT16344 is a 1-to-4 address driver used in applications where four separate memory locations must be addressed by a single address.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYPI	UNIT		
STWBOL	PARAMETER	T _{amb} = 25°C	2.5V	3.3V	ONT	
t _{PLH} t _{PHL}	Propagation delay nAx to nBx or nBx to nAx	C _L = 50pF	2.5 1.9	1.9 1.6	ns	
C _{IN}	Input capacitance DIR, OE	V _I = 0V or V _{CC}	3	3	pF	
C _{Out}	Output capacitance	$V_{I/O} = 0V \text{ or } V_{CC}$	9	9	pF	
I _{CCZ}	Total supply current	Outputs disabled	40	70	μΑ	

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
56-Pin Plastic SSOP Type III	–40°C to +85°C	74ALVT16344 DL	AV16344 DL	SOT371-1
56-Pin Plastic TSSOP Type II	–40°C to +85°C	74ALVT16344 DGG	AV16344 DGG	SOT364-1

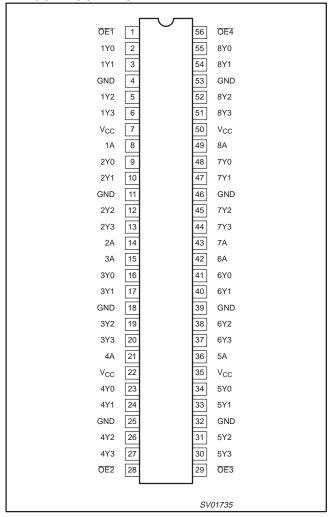
PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
8, 14, 15, 21, 36, 42, 43, 49	nA	Data inputs
2, 3, 5, 6, 9, 10, 12, 13, 16, 17, 19, 20, 23, 24, 26, 27, 30,31, 33, 34, 37, 38, 40, 44, 45, 47, 48, 51, 52, 54, 55,	nΥχ	Data outputs
1, 28, 29, 56	ŌĒ	Output enable inputs (active-Low)
4, 11, 18, 25, 32, 39, 46, 53	GND	Ground (0V)
7, 22, 35, 50	V _{CC}	Positive supply voltage

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PIN CONFIGURATION



FUNCTION TABLE

INPU	JTS	OUTPUTS	OPERATING MODE
OE	nA	nYx	OF ENATING WIDDE
L	L	L	Transparent
L	Η	Н	Transparent
Н	Χ	Z	High impedance

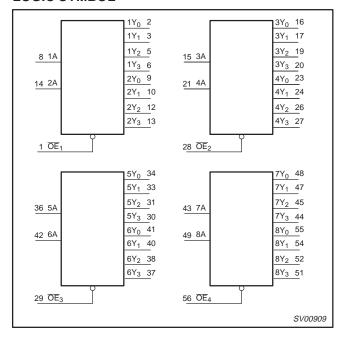
X = Don't care

Z = High impedance "off" state

H = High voltage level

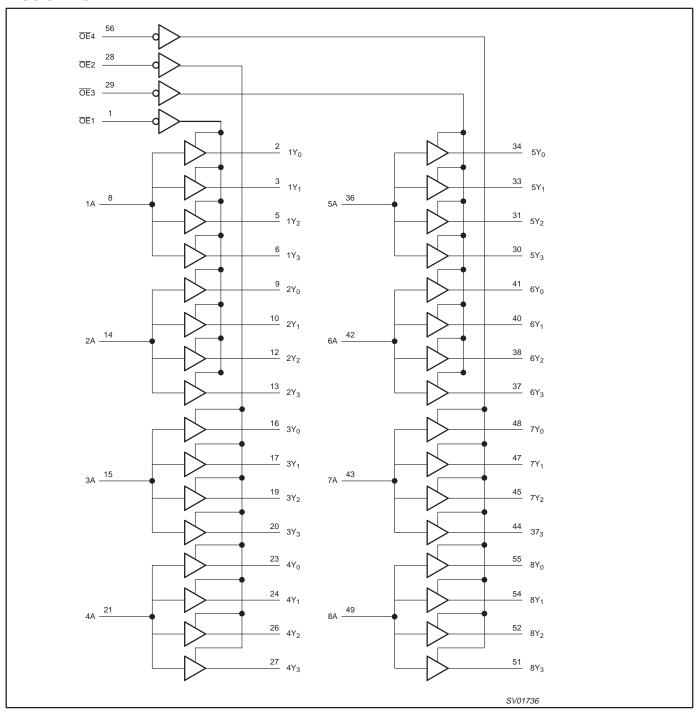
L = Low voltage level

LOGIC SYMBOL



74ALVT16344

LOGIC DIAGRAM



2.5V/3.3V 1-to-4 address driver (3-State)

74ALVT16344

ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V
I _{IK}	DC input diode current	V _I < 0	-50	mA
VI	DC input voltage ³		-0.5 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	Output in Off or High state	-0.5 to +7.0	V
la	DC output current	Output in Low state	128	mA
IOUT	DC output current	Output in High state	-64	
T _{stg}	Storage temperature range		-65 to +150	°C

NOTES:

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	2.5V RANGE LIMITS		3.3V RANGE LIMITS		UNIT
STMBOL	TANAMETER	MIN	MAX	MIN	MAX	ONIT
V _{CC}	DC supply voltage	2.3	2.7	3.0	3.6	V
VI	Input voltage	0	5.5	0	5.5	V
V _{IH}	High-level input voltage	1.7		2.0		V
V _{IL}	Input voltage		0.7		0.8	V
Гон	High-level output current		-8		-32	mA
la.	Low-level output current		8		32	
loL	Low-level output current; current duty cycle ≤ 50%; f ≥ 1kHz		24		64	mA
Δt/Δν	Input transition rise or fall rate; Outputs enabled		10		10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	-40	+85	°C

^{1.} Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

^{3.} The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

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DC ELECTRICAL CHARACTERISTICS (3.3V \pm 0.3V RANGE)

					LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS		TEST CONDITIONS Temp = -40° C to $+85^{\circ}$ C			UNIT
				MIN	TYP ¹	MAX	
V _{IK}	Input clamp voltage	$V_{CC} = 3.0V; I_{IK} = -18mA$			-0.85	-1.2	V
V _{OH}	High-level output voltage	$V_{CC} = 3.0 \text{ to } 3.6\text{V}; I_{OH} = -100\mu\text{A}$		V _{CC} -0.2	V _{CC}		
VОН	I light-level output voltage	$V_{CC} = 3.0V; I_{OH} = -32mA$		2.0	2.3		
		$V_{CC} = 3.0V; I_{OL} = 100\mu A$			0.07	0.2	
V_{OL}	Low-level output voltage	$V_{CC} = 3.0V; I_{OL} = 16mA$			0.25	0.4	V
		$V_{CC} = 3.0V; I_{OL} = 32mA$			0.3	0.5	
		$V_{CC} = 3.0V; I_{OL} = 64mA$			0.4	0.55	1
		$V_{CC} = 3.6V$; $V_I = V_{CC}$ or GND	Control pins		0.1	±1	
		$V_{CC} = 0 \text{ or } 3.6V; V_I = 5.5V$	Control pins		0.1	10	
II	Input leakage current	$V_{CC} = 3.6V; V_I = 5.5V$			0.1	10	μА
		$V_{CC} = 3.6V; V_I = V_{CC}$	Data pins ⁴		0.1	1	
		$V_{CC} = 3.6V; V_I = 0$	1		0.1	-5	
I _{OFF}	Off current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$	•		0.1	±100	μΑ
	Bus Hold current	$V_{CC} = 3V; V_I = 0.8V$		75	130		μΑ
I_{HOLD}	A or B outputs	$V_{CC} = 3V; V_I = 2.0V$		- 75	-200		μΑ
	A of B outputs	$V_{I} = 0V \text{ to } 3.6V; V_{CC} = 3.6V^{6}$		±500			μΑ
I _{EX}	Current into an output in the High state when V _O > V _{CC}	V _O = 5.5V; V _{CC} = 3.0V			10	125	μА
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2V$; $V_O = 0.5V$ to V_{CC} ; $V_I = GNE$ OE/OE = Don't care	or V _{CC} ;		1	±100	μА
l _{OZH}	3-State output High current	$V_{CC} = 3.6V; V_O = 3.0V; V_I = V_{IL} \text{ or } V_{IH}$			0.5	5	μΑ
I _{OZL}	3-State output Low current	$V_{CC} = 3.6V; V_{O} = 0.5V; V_{I} = V_{IL} \text{ or } V_{IH}$			0.5	-5	μА
I _{CCH}		$V_{CC} = 3.6V$; Outputs High, $V_I = GND$ or V_{CC} , $I_{O} = 0$			0.06	0.1	
I _{CCL}	Quiescent supply current	$V_{CC} = 3.6V$; Outputs Low, $V_I = GND$ or V_{CC} , $I_{O} = 0$			7	8.5	mA
I _{CCZ}	1	$V_{CC} = 3.6V$; Outputs Disabled; $V_I = GNE$	O or V_{CC} , $I_{O} = 0^5$		0.06	0.1	1
ΔI_{CC}	Additional supply current per input pin ²	V_{CC} = 3V to 3.6V; One input at V_{CC} -0.6 Other inputs at V_{CC} or GND	V,		0.05	0.4	mA

- All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.
 This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
 This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 3.3V ± 0.3V a transition time of 100µsec is permitted. This parameter is valid for T_{amb} = 25°C only.
- Unused pins at V_{CC} or GND.
- 5. I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
 6. This is the bus hold overdrive current required to force the input to the opposite state.

AC CHARACTERISTICS (3.3V \pm 0.3V RANGE) GND = 0V, $t_R=t_F=2.5 ns,\, C_L=50 pF,\, R_L=500 \Omega$

SYMBOL	PARAMETER	WAVEFORM	T _{ar}	UNIT		
			MIN	TYP	MAX	
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	1	0.5 0.5	1.9 1.6	3.0 2.5	ns
t _{PZH} t _{PZL}	Output enable time to High and Low level	2	1.0 1.0	2.8 2.3	4.7 3.6	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	2	1.0 1.0	3.7 2.3	5.5 4.1	ns

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DC ELECTRICAL CHARACTERISTICS (2.5V \pm 0.2V RANGE)

		TEST CONDITIONS		LIMITS Temp = -40°C to +85°C			UNIT
SYMBOL	PARAMETER						
				MIN	TYP ¹	MAX	
V _{IK}	Input clamp voltage	$V_{CC} = 2.3V; I_{IK} = -18mA$			-0.85	-1.2	V
V	High-level output voltage	$V_{CC} = 2.3 \text{ to } 2.7 \text{V}; I_{OH} = -100 \mu\text{A}$		V _{CC} -0.2	V _{CC}		V
V _{OH}	I ligit-level output voltage	$V_{CC} = 2.3V; I_{OH} = -8mA$		1.7	2.1		l
\/-·	Low-level output voltage	$V_{CC} = 2.3V; I_{OL} = 100\mu A$			0.07	0.2	V
V_{OL}	Low-level output voltage	V _{CC} = 2.3V; I _{OL} = 24mA			0.3	0.5	\ \ \
		$V_{CC} = 2.7V$; $V_I = V_{CC}$ or GND	Control pins		0.1	±1	
		$V_{CC} = 0 \text{ or } 2.7V; V_I = 5.5V$	Control pins		0.1	10	
I_{\parallel}	Input leakage current	$V_{CC} = 2.7V; V_I = 5.5V$			0.1	10	μΑ
		$V_{CC} = 2.7V; V_I = V_{CC}$	Data pins ⁴		0.1	1	
		$V_{CC} = 2.7V; V_I = 0$	1		0.1	-5	
l _{OFF}	Off current	$V_{CC} = 0V$; V_I or $V_O = 0$ to 4.5V	-		0.1	±100	μА
I _{HOLD} 6	Bus Hold current	$V_{CC} = 2.5V; V_I = 0.8V$			105		μА
	A inputs	V _{CC} = 2.5V; V _I = 2.0V			10		μА
I _{EX}	Current into an output in the High state when V _O > V _{CC}	V _O = 5.5V; V _{CC} = 2.3V			10	125	μΑ
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2V$; $V_O = 0.5V$ to V_{CC} ; $V_I = GNE$ OE/OE = Don't care	or V _{CC}		1	100	μΑ
I _{OZH}	3-State output High current	$V_{CC} = 2.7V$; $V_O = 2.3V$; $V_I = V_{IL}$ or V_{IH}			0.5	5	μА
I _{OZL}	3-State output Low current	$V_{CC} = 2.7V$; $V_O = 0.5V$; $V_I = V_{IL}$ or V_{IH}			0.5	- 5	μА
I _{CCH}		$V_{CC} = 2.7V$; Outputs High, $V_I = GND$ or V_{CC} , $I_{O} = 0$			0.04	0.1	
I _{CCL}	Quiescent supply current	$V_{CC} = 2.7V$; Outputs Low, $V_I = GND$ or V_{CC} , $I_{O} = 0$			5.0	6.5	mA
I _{CCZ}	1	$V_{CC} = 2.7V$; Outputs Disabled; $V_I = GND$ or V_{CC} , $I_{O} = 0^5$			0.04	0.1	
Δl _{CC}	Additional supply current per input pin ²	V_{CC} = 2.3V to 2.7V; One input at V_{CC} -0 Other inputs at V_{CC} or GND	.6V,		0.04	0.4	mA

- All typical values are at V_{CC} = 2.5V and T_{amb} = 25°C.
 This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
 This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 2.5V ± 0.2V a transition time of 100µsec is permitted. This parameter is valid for T_{amb} = 25°C only.
 Unused pins at V_{CC} or GND.
 I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
 Not guaranteed.

AC CHARACTERISTICS (2.5V \pm 0.2V RANGE) GND = 0V, $t_R = t_F = 2.5 ns, \, C_L = 50 pF, \, R_L = 500 \Omega$

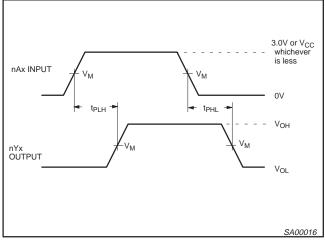
				UNIT		
SYMBOL	PARAMETER	WAVEFORM	T _{an} V _C			
			MIN	TYP	MAX	
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	1	0.5 0.5	2.5 1.9	4.2 3.9	ns
[†] PZH [†] PZL	Output enable time to High and Low level	2	1.0 1.0	3.5 2.8	6.1 4.6	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	2	1.0 1.0	2.8 3.1	5.3 4.9	ns

2.5V/3.3V 1-to-4 address driver (3-State)

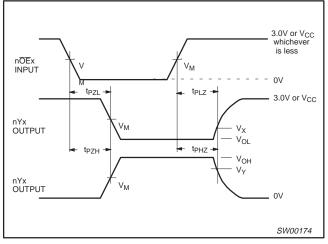
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AC WAVEFORMS

 V_M = 1.5V for V_{CC} ≥ 3.0V; V_M = V_{CC} /2 for V_{CC} ≤ 2.7V V_X = V_{OL} + 0.3V for V_{CC} ≥ 3.0V; V_X = V_{OL} + 0.15V for V_{CC} ≤ 2.7V V_Y = V_{OH} - 0.3V for V_{CC} ≥ 3.0V; V_Y = V_{OH} - 0.15V for V_{CC} ≤ 2.7V

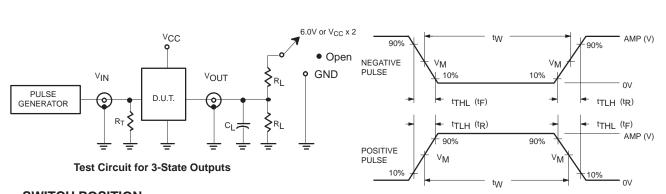


Waveform 1. Input (nAx) to Output (nYx) Propagation Delays



Waveform 2. 3-State Output Enable and Disable Times

TEST CIRCUIT AND WAVEFORM



SWITCH POSITION

TEST	SWITCH
t _{PLZ} /t _{PZL}	6V or V _{CC x 2}
t _{PLH} /t _{PHL}	Open
t _{PHZ} /t _{PZH}	GND

DEFINITIONS

 R_L = Load resistor; see AC CHARACTERISTICS for value.

 $C_L = Load$ capacitance includes jig and probe capacitance: See AC CHARACTERISTICS for value.

R_T = Termination resistance should be equal to Z_{OUT} of pulse generators.

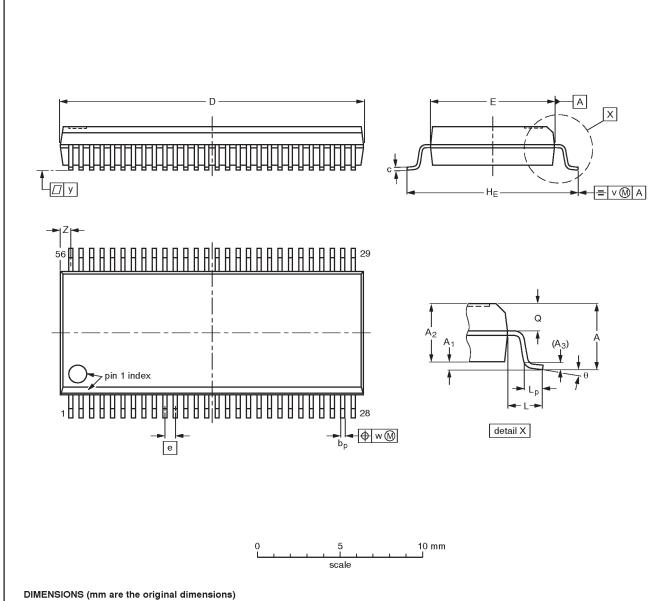
FA BALL V	INPUT PULSE REQUIREMENTS							
FAMILY	Amplitude	Rep. Rate	t _W	t _R	t _F			
74ALVT16	3.0V or V _{CC} whichever is less	≤10MHz	500ns	≤2.5ns	≤2.5ns			

SW00205

74ALVT16344

SSOP56: plastic shrink small outline package; 56 leads; body width 7.5 mm

SOT371-1



UNIT	A max.	Α ₁	A ₂	A ₃	рb	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	2.8	0.4 0.2	2.35 2.20	0.25	0.3 0.2	0.22 0.13	18.55 18.30	7.6 7.4	0.635	10.4 10.1	1.4	1.0 0.6	1.2 1.0	0.25	0.18	0.1	0.85 0.40	8° 0°

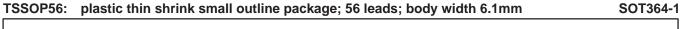
Note

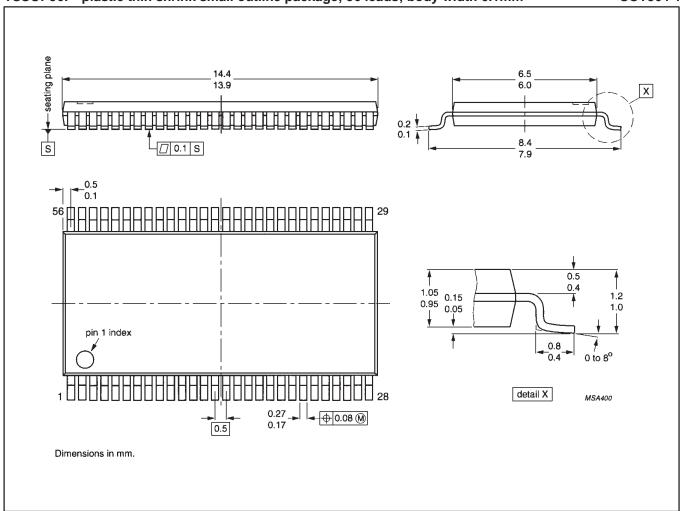
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE	
SOT371-1		MO-118AB				93-11-02 95-02-04	

2.5V/3.3V 1-to-4 address driver (3-State)

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NOTES

2.5V/3.3V 1-to-4 address driver (3-State)

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
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^[1] Please consult the most recently issued datasheet before initiating or completing a design.

Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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